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January 2001

FDC6312P Dual P-Channel 1.8V PowerTrench[®] Specified MOSFET

General Description

SEMICONDUCTOR IM

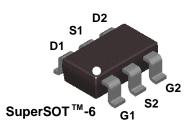
These P-Channel 1.8V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain low gate charge for superior switching performance.

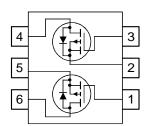
Applications

- Power management
- Load switch

Features

- -2.3 A, -20 V. $R_{DS(ON)} = 115 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$ $R_{DS(ON)} = 155 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$ $R_{DS(ON)} = 225 \text{ m}\Omega @ V_{GS} = -1.8 \text{ V}$
- + High performance trench technology for extremely low $R_{_{\mbox{DS}(\mbox{ON})}}$
- SuperSOTTM-6 package: small footprint (72% smaller than standard SO-8); low profile (1mm thick)





Absolute Maximum Ratings T_{A=25°C} unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-20	V
V _{GSS}	Gate-Source Voltage		±8	V
I _D	Drain Current – Continuous	(Note 1a)	-2.3	A
	– Pulsed		-7	
P _D	Power Dissipation for Single Operation	(Note 1a)	0.96	W
		(Note 1b)	0.9	
		(Note 1c)	0.7	
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-55 to +150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	130	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	60	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.312	FDC6312P	13"	12mm	3000 units
.012	10000121	10	1211111	

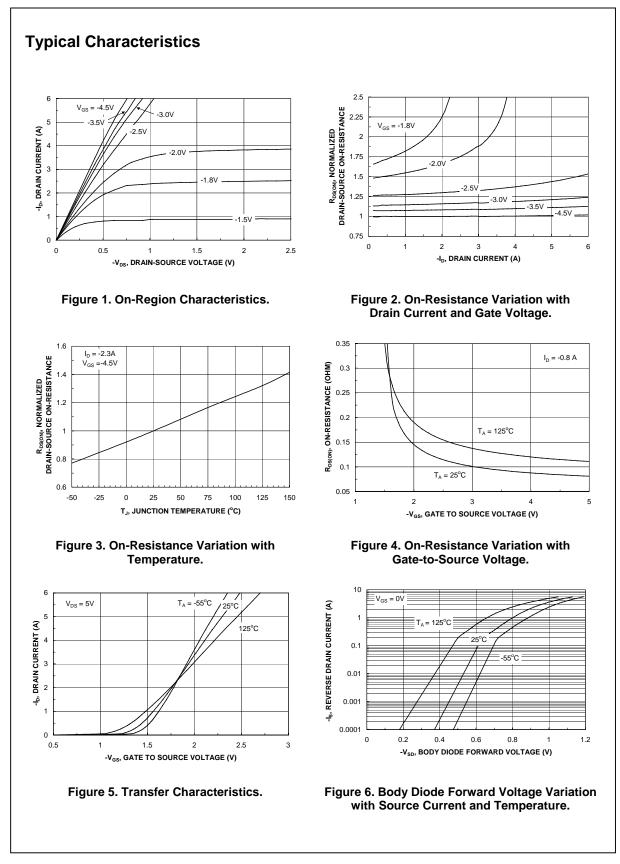
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FDC6312P

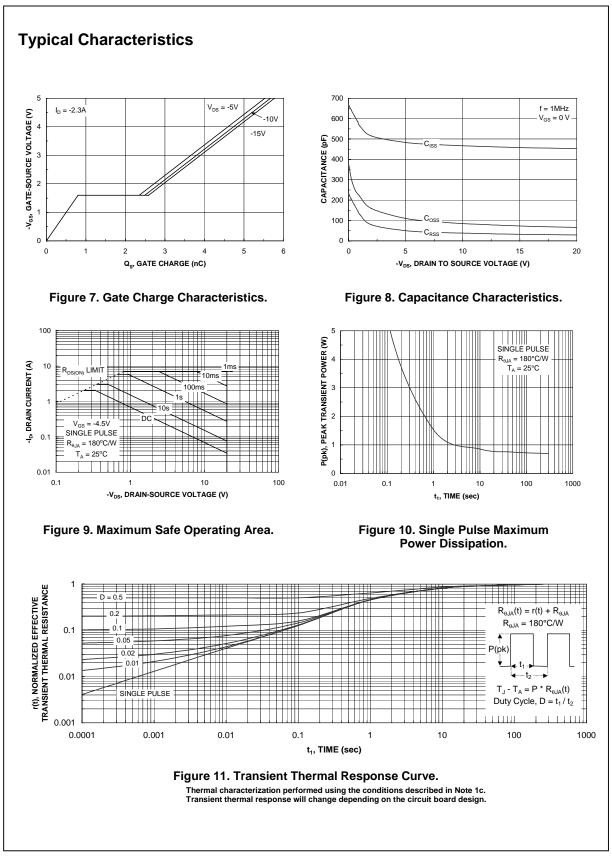
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	V mV/°C μA nA NA V mV/°C mΩ A S
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	mV/°C μA nA nA V mV/°C mΩ
$\begin{array}{c c c c c c c c c c c c c c c c c c c $	μA nA nA V mV/°C mΩ
IGSSFGate-Body Leakage, Forward $V_{GS} = 8 \text{ V}$, $V_{DS} = 0 \text{ V}$ 100IGSSRGate-Body Leakage, Reverse $V_{GS} = -8 \text{ V}$, $V_{DS} = 0 \text{ V}$ -100On Characteristics (Note 2)VGS(th)Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu\text{A}$ $-0.4 \ -0.9 \ -1.5$ $\Delta V_{GS(th)}$ Gate Threshold Voltage $I_D = -250 \ \mu\text{A}$, Referenced to 25°C2 ΔT_J Temperature Coefficient $I_D = -250 \ \mu\text{A}$, Referenced to 25°C2 $R_{DS(on)}$ Static Drain-Source $V_{GS} = -4.5 \text{ V}$, $I_D = -2.3 \text{ A}$ 92 $On-Resistance$ $V_{GS} = -1.8 \text{ V}$, $I_D = -1.6 \text{ A}$ 116 $V_{GS} = -1.8 \text{ V}$, $I_D = -2.3 \text{ A}$, $T_J = 125^{\circ}\text{C}$ 112 $I_{D(on)}$ On-State Drain Current $V_{GS} = -4.5 \text{ V}$, $V_{DS} = -5 \text{ V}$ -7 $I_{D(on)}$ On-State Drain Current $V_{GS} = -4.5 \text{ V}$, $V_{DS} = -5 \text{ V}$ -7 $I_{D(on)}$ On-State Drain Current $V_{GS} = -4.5 \text{ V}$, $I_D = -3.5 \text{ A}$ 5.3Dynamic Characteristics C_{ISS} Input Capacitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$,467 C_{ISS} Reverse Transfer Capacitance $I_D = -1.0 \text{ MHz}$ 38Switching Characteristics (Note 2) $I_D = -2.3 \text{ A}$ 38 $I_D = -3.5 \text{ A}$	
IGSSRGate-Body Leakage, Reverse $V_{GS} = -8 \text{ V}$, $V_{DS} = 0 \text{ V}$ -100On Characteristics (Note 2)(Note 2) $V_{GS}(th)$ Gate Threshold Voltage $V_{DS} = V_{GS}$, $I_D = -250 \ \mu\text{A}$ -0.4 -0.9 -1.5 $\Delta V_{GS}(th)$ ΔT_J Gate Threshold Voltage Temperature Coefficient $I_D = -250 \ \mu\text{A}$, Referenced to 25°C 2 $R_{DS}(on)$ Static Drain-Source On-Resistance $V_{GS} = -4.5 \text{ V}$, $I_D = -2.3 \text{ A}$ $V_{GS} = -1.8 \text{ V}$, $I_D = -1.6 \text{ A}$ $V_{GS} = -1.8 \text{ V}$, $I_D = -1.6 \text{ A}$ $V_{GS} = -1.8 \text{ V}$, $I_D = -2.3 \text{ A}$, $T_J = 125^{\circ}\text{C}$ 92115Ib(on)On-State Drain Current $V_{GS} = -4.5 \text{ V}$, $V_{DS} = -5 \text{ V}$ -7 77 g_{FS} Forward Transconductance $V_{DS} = -5 \text{ V}$, $I_D = -3.5 \text{ A}$ 5.37 Dynamic Characteristics C_{rss} Reverse Transfer Capacitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1.0 \text{ MHz}$ 46785Switching Characteristics (Note 2) $V_{OS} = -10 \text{ V}$ $V_{GS} = 0 \text{ V}$, $38 \text{ Interval of the transfer Capacitance}$ 85100	nA V mV/°C mΩ
On Characteristics (Note 2)(Note 2) $V_{GS(th)}$ Gate Threshold Voltage Temperature Coefficient $V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$ -0.4 -0.9 -1.5 $\Delta V_{GS(th)}$ Gate Threshold Voltage Temperature Coefficient $I_D = -250 \ \mu A$, Referenced to 25° C22 $R_{DS(on)}$ Static Drain–Source On–Resistance $V_{GS} = -4.5 \ V$, $I_D = -2.3 \ A$ 92115 $V_{GS} = -1.8 \ V$, $I_D = -1.9 \ A$ 116155 $V_{GS} = -4.5 \ V$, $I_D = -1.6 \ A$ 166225 $V_{GS} = -4.5 \ V$, $I_D = -2.3A$, $T_J = 125^{\circ}$ C112150 $I_{D(on)}$ On–State Drain Current $V_{GS} = -4.5 \ V$, $I_D = -2.3A$, $T_J = 125^{\circ}$ C112 $I_{D(on)}$ On–State Drain Current $V_{GS} = -4.5 \ V$, $I_D = -3.5 \ A$ 5.3 Dynamic Characteristics $V_{DS} = -5 \ V$, $I_D = -3.5 \ A$ 5.3CissInput Capacitance $V_{DS} = -10 \ V$, $V_{GS} = 0 \ V$,467 C_{rss} Reverse Transfer Capacitance $I_B = 1.0 \ MHz$ 85Switching Characteristics (Note 2)State 2	V mV/°C mΩ A
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$ \begin{array}{c c c c c c c c c } \hline \Delta V_{GS}(h) \\ \Delta T_J & Gate Threshold Voltage Temperature Coefficient & I_D = -250 \ \mu A, Referenced to 25^{\circ}C & 2 \\ \hline R_{DS(on)} & Static Drain–Source On–Resistance & V_{GS} = -4.5 \ V, \ I_D = -2.3 \ A \\ V_{GS} = -2.5 \ V, \ I_D = -1.9 \ A \\ V_{GS} = -2.5 \ V, \ I_D = -1.9 \ A \\ V_{GS} = -1.8 \ V, \ I_D = -1.6 \ A \\ V_{GS} = -4.5 \ V, \ I_D = -2.3 \ A, \ T_J = 125^{\circ}C & 116 \\ 166 & 225 \\ 112 & 150 \\ \hline I_{D(on)} & On–State Drain Current & V_{GS} = -4.5 \ V, \ V_{DS} = -5 \ V & -7 & 12 \\ \hline I_{D(on)} & On–State Drain Current & V_{GS} = -4.5 \ V, \ V_{DS} = -5 \ V & -7 & 12 \\ \hline I_{D(on)} & On–State Drain Current & V_{GS} = -4.5 \ V, \ V_{DS} = -5 \ V & -7 & 12 \\ \hline I_{D(on)} & On–State Drain Current & V_{DS} = -5 \ V, \ I_D = -3.5 \ A & 5.3 & 12 \\ \hline Dynamic Characteristics \\ \hline C_{iss} & Input Capacitance & V_{DS} = -10 \ V, \ V_{GS} = 0 \ V, \\ \hline C_{oss} & Output Capacitance & f = 1.0 \ MHz & 85 \\ \hline C_{rss} & Reverse Transfer Capacitance & 38 \\ \hline Switching Characteristics \ (Note 2) & 12 \\ \hline \end{array}$	mV/°C mΩ A
$\begin{array}{c c c c c c c c c } & Temperature Coefficient & & & & & & & & & & & & & & & & & & &$	mΩ A
$ \begin{array}{ c c c c c c c } \hline On-Resistance & V_{GS}=-2.5 \ V, \ \ I_D=-1.9 \ A \\ V_{GS}=-1.8 \ V, \ \ I_D=-1.6 \ A \\ V_{GS}=-4.5 \ V, \ \ I_D=-1.6 \ A \\ V_{GS}=-4.5 \ V, \ \ I_D=-2.3 \ A, \ \ T_J=125^\circ C \\ \hline 112 & 150 \\ \hline 112 & 150$	A
V _{GS} =-4.5 V, I _D =-2.3A, T _J =125°C 112 150 I _{D(on)} On-State Drain Current V _{GS} = -4.5 V, V _{DS} = -5 V -7 g _{FS} Forward Transconductance V _{DS} = -5 V, I _D = -3.5 A 5.3 Dynamic Characteristics V _{DS} = -10 V, V _{GS} = 0 V, I _D = -3.5 A 5.3 C _{iss} Input Capacitance V _{DS} = -10 V, V _{GS} = 0 V, I _D = -3.5 A 85 C _{iss} Output Capacitance I = 1.0 MHz 85 C _{rss} Reverse Transfer Capacitance 38 38	
$I_{D(on)}$ On-State Drain Current $V_{GS} = -4.5 \text{ V}$, $V_{DS} = -5 \text{ V}$ -7 g_{FS} Forward Transconductance $V_{DS} = -5 \text{ V}$, $I_D = -3.5 \text{ A}$ 5.3 Dynamic Characteristics C_{iss} Input Capacitance $V_{DS} = -10 \text{ V}$, $V_{GS} = 0 \text{ V}$, 467 C_{oss} Output Capacitance $f = 1.0 \text{ MHz}$ 85 CrissReverse Transfer Capacitance 38 38 Switching Characteristics (Note 2)	
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Crss Reverse Transfer Capacitance 38 Switching Characteristics (Note 2)	pF
Switching Characteristics (Note 2)	pF
	pF
two Turn-On Delay Time $V_{12} = 10 V_{12} = 10$	
$v_{DD} = -10^{\circ} v$, $i_D = -1 A$, $0^{\circ} 10^{\circ} 10^{\circ}$	ns
t_r Turn–On Rise Time $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$ 13 23	ns
t _{d(off)} Turn–Off Delay Time 18 32	ns
t _r Turn–Off Fall Time 8 16	ns
Q_g Total Gate Charge $V_{DS} = -10 V$, $I_D = -2.3 A$, $4.4 7$	nC
Q_{gs} Gate-Source Charge $V_{GS} = -4.5 V$ 1.0	nC
Q _{gd} Gate–Drain Charge 0.8	nC
Drain–Source Diode Characteristics and Maximum Ratings	
Is Maximum Continuous Drain–Source Diode Forward Current –0.8	Α
V_{SD} Drain-Source Diode Forward $V_{GS} = 0 V$, $I_S = -0.8 A$ (Note 2) $-0.7 -1.2$	V

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%

FDC6312P Rev C (W)



FDS6312P



FDS6312P

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